

Notice of References Cited

Application/Control No.

10/565,286

Applicant(s)/Patent Under
Reexamination
CHO ET AL.

Examiner

Kortney L. Klinkel

Art Unit

1611

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 01/84930	11-2001	WO	Kang et al.	A01N 37/44
	O					
	P					
	Q					
	R					
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NON-PATENT DOCUMENTS

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